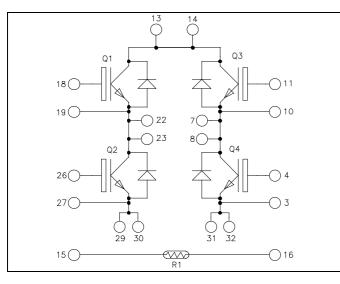
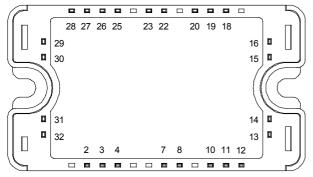


# APTGF30H60T3G

## Full - Bridge NPT IGBT Power Module





All multiple inputs and outputs must be shorted together Example: 13/14 ; 29/30 ; 22/23 ...

## $V_{CES} = 600V$ $I_{C} = 30A$ @ Tc = 80°C

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 50 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant

## Absolute maximum ratings

| Symbol           | Parameter                             |                      | Max ratings | Unit |
|------------------|---------------------------------------|----------------------|-------------|------|
| V <sub>CES</sub> | Collector - Emitter Breakdown Voltage |                      | 600         | V    |
| т                | Continuous Collector Current          | $T_C = 25^{\circ}C$  | 42          |      |
| I <sub>C</sub>   | Continuous Conector Current           | $T_C = 80^{\circ}C$  | 30          | А    |
| I <sub>CM</sub>  | Pulsed Collector Current              | $T_C = 25^{\circ}C$  | 100         |      |
| $V_{GE}$         | Gate – Emitter Voltage                |                      | ±20         | V    |
| P <sub>D</sub>   | Maximum Power Dissipation             | $T_C = 25^{\circ}C$  | 140         | W    |
| RBSOA            | Reverse Bias Safe Operating Area      | $T_j = 125^{\circ}C$ | 60A@500V    |      |

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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## All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

## **Electrical Characteristics**

| Symbol              | Characteristic                      | Test Conditions   |                        | Min | Тур | Max  | Unit |
|---------------------|-------------------------------------|---|------------------------|-----|-----|------|------|
| I                   | Zero Gate Voltage Collector Current | $V_{GE} = 0V$   | $T_j = 25^{\circ}C$    |     |     | 250  | μA   |
| I <sub>CES</sub>    | Zero Gate voltage Collector Current | $V_{CE} = 600V$   | $T_{j} = 125^{\circ}C$ |     |     | 500  | μА   |
| V                   | Collector Emitter on Voltage        | $ \begin{array}{c} V_{GE} = 15V \\ I_C = 30A \end{array} \begin{array}{c} T_j = 25^{\circ}C \\ T_j = 125^{\circ}C \end{array} \end{array} $ | $T_j = 25^{\circ}C$    | 1.7 | 2.0 | 2.45 | V    |
| V <sub>CE(on)</sub> |                                     |   |                        | 2.2 |     | v    |      |
| V <sub>GE(th)</sub> | Gate Threshold Voltage              | $V_{GE} = V_{CE}, I_C = 1mA$  |                        | 4   |     | 6    | V    |
| I <sub>GES</sub>    | Gate – Emitter Leakage Current      | $V_{GE} = 20V, V_{CE} = 0V$   |                        |     |     | 400  | nA   |

## **Dynamic Characteristics**

| Symbol              | Characteristic               | Test Conditions   |                      | Min | Тур  | Max | Unit |
|---------------------|------------------------------|---|----------------------|-----|------|-----|------|
| Cies                | Input Capacitance            | $V_{GE} = 0V$ $V_{CE} = 25V$                                  |                      |     | 1350 |     |      |
| C <sub>oes</sub>    | Output Capacitance           |   |                      |     | 193  |     | pF   |
| C <sub>res</sub>    | Reverse Transfer Capacitance | f = 1MHz  |                      |     | 120  |     |      |
| Qg                  | Total gate Charge            | $V_{GE} = 15V$  |                      |     | 99   |     | nC   |
| Q <sub>ge</sub>     | Gate – Emitter Charge        | $V_{Bus} = 300V$  |                      |     | 10   |     |      |
| Q <sub>gc</sub>     | Gate – Collector Charge      | $I_C = 30A$   |                      |     | 60   |     |      |
| T <sub>d(on)</sub>  | Turn-on Delay Time           | Inductive Switching (25°C)                                    |                      |     | 30   |     |      |
| T <sub>r</sub>      | Rise Time                    | $V_{GE} = 15V$  |                      |     | 12   |     |      |
| T <sub>d(off)</sub> | Turn-off Delay Time          | $V_{Bus} = 400V$<br>$I_C = 30A$                               |                      | 80  |      | ns  |      |
| T <sub>f</sub>      | Fall Time                    | $R_G = 6.8\Omega$   |                      | 15  |      |     |      |
| T <sub>d(on)</sub>  | Turn-on Delay Time           | Inductive Switch  | ning (125°C)         |     | 32   |     |      |
| Tr                  | Rise Time                    | $V_{GE} = 15V$ $V_{Bus} = 400V$ $I_C = 30A$ $R_G = 6.8\Omega$ |                      |     | 12   |     |      |
| T <sub>d(off)</sub> | Turn-off Delay Time          |   |                      |     | 90   |     | ns   |
| T <sub>f</sub>      | Fall Time                    |   |                      |     | 21   |     |      |
| Eon                 | Turn-on Switching Energy     | $V_{GE} = 15V$ $V_{Bus} = 400V$                               | $T_j = 125^{\circ}C$ |     | 0.3  |     | T    |
| E <sub>off</sub>    | Turn-off Switching Energy    | $I_{C} = 30A$ $R_{G} = 6.8\Omega$                             | $T_j = 125^{\circ}C$ |     | 0.8  |     | mJ   |

## Reverse diode ratings and characteristics

| Symbol           | Characteristic                          | Test Conditions                        | Min                    | Тур | Max | Unit |     |
|------------------|---|--|------------------------|-----|-----|------|-----|
| V <sub>RRM</sub> | Maximum Peak Repetitive Reverse Voltage |  |                        | 600 |     |      | V   |
| I <sub>RM</sub>  | Mariana Decement Locks of Comment       | V <sub>R</sub> =600V                   | $T_j = 25^{\circ}C$    |     |     | 150  | ۸   |
| I <sub>RM</sub>  | Maximum Reverse Leakage Current         | v <sub>R</sub> -000 v                  | $T_{j} = 125^{\circ}C$ |     |     | 500  | μA  |
| $I_F$            | DC Forward Current                      |  | $Tc = 80^{\circ}C$     |     | 15  |      | А   |
|                  |   | $I_F = 15A$                            |                        |     | 1.6 | 1.8  |     |
| V <sub>F</sub>   | Diode Forward Voltage                   | $I_{\rm F} = 30 {\rm A}$               |                        |     | 1.9 |      | V   |
|                  |   | $I_F = 15A$                            | $T_j = 125^{\circ}C$   |     | 1.4 |      |     |
| t <sub>rr</sub>  | Reverse Recovery Time                   | $I_{\rm F} = 15 A$ $V_{\rm R} = 400 V$ | $T_j = 25^{\circ}C$    |     | 40  |      | ns  |
| urr              | Reverse Recovery Time                   |  | $T_{j} = 125^{\circ}C$ |     | 150 |      | 115 |
| Q <sub>rr</sub>  | Reverse Recovery Charge                 | $di/dt = 200 \text{ A}/\mu\text{s}$    | $T_j = 25^{\circ}C$    |     | 95  |      | nC  |
|                  |   |  | $T_{j} = 125^{\circ}C$ |     | 520 |      | ne  |

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# APTGF30H60T3G

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

| Symbol          | Characteristic                                       | Min | Тур  | Max | Unit |
|-----------------|--|-----|------|-----|------|
| R <sub>25</sub> | Resistance @ 25°C                                    |     | 50   |     | kΩ   |
| B 25/85         | $T_{25} = 298.15 \text{ K}$                          |     | 3952 |     | K    |
| -               | $R_{-} = \frac{R_{25}}{1}$ T: Thermistor temperature |     |      |     |      |

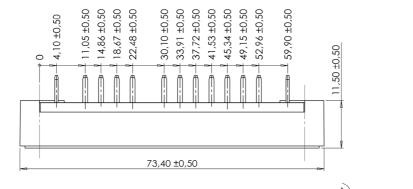
value at T

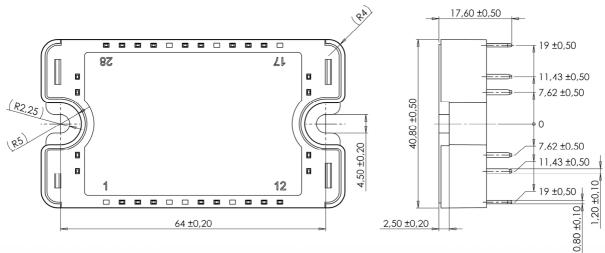
$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor to R<sub>T</sub>: Thermistor

## Thermal and package characteristics

| Symbol                    | Characteristic  |             |       | Min  | Тур | Max | Unit |
|---------------------------|---|-------------|-------|------|-----|-----|------|
| R <sub>thJC</sub>         | Junction to Case Thermal Resistance                           |             | IGBT  |      |     | 0.9 | °C/W |
| <b>R</b> <sub>th</sub> JC |   |             | Diode |      |     | 2.0 |      |
| VISOL                     | RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz |             |       | 4000 |     |     | V    |
| TJ                        | Operating junction temperature range                          |             |       | -40  |     | 150 |      |
| T <sub>STG</sub>          | Storage Temperature Range                                     |             | -40   |      | 125 | °C  |      |
| T <sub>C</sub>            | Operating Case Temperature                                    |             |       | -40  |     | 100 |      |
| Torque                    | Mounting torque   | To heatsink | M4    | 2    |     | 3   | N.m  |
| Wt                        | Package Weight  |             |       |      |     | 110 | g    |

### SP3 Package outline (dimensions in mm)



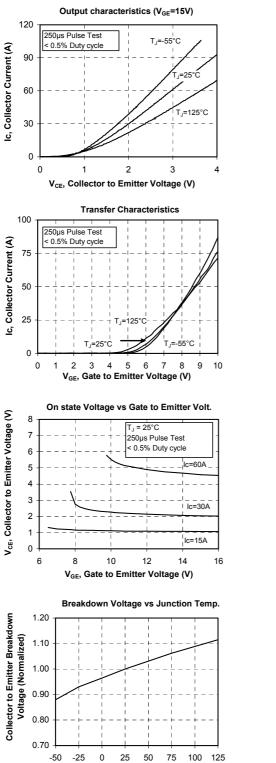


See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

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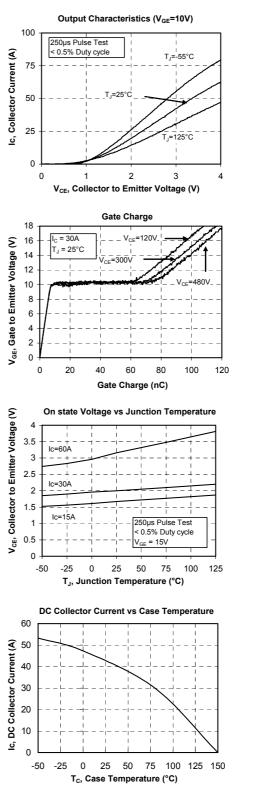


#### **Typical Performance Curve**



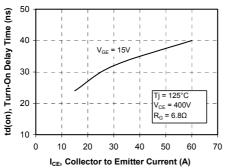
T<sub>J</sub>, Junction Temperature (°C)

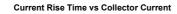
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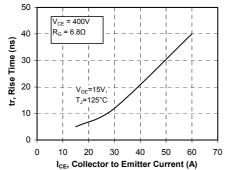


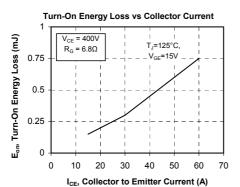


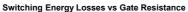
Turn-On Delay Time vs Collector Current

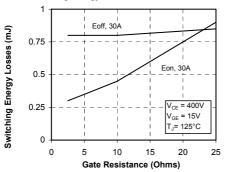




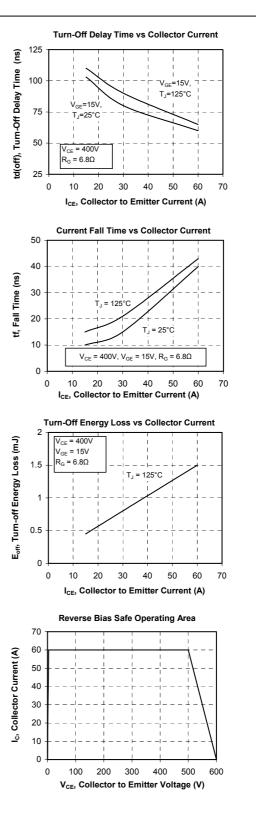






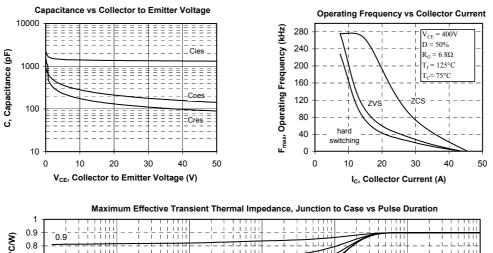


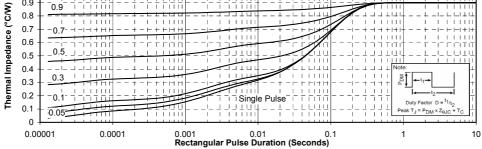
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